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ON Semiconductor®

FQD2N100 / FQU2N100 N-Channel QFET® MOSFET 1000 V, 1.6 A, 9 Ω

Description

This N-Channel enhancement mode power MOSFET is produced using ON Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

Features

- 1.6 A, 1000 V, R_{DS(on)} = 9 Ω (Max.)@ V_{GS} = 10 V, I_D = 0.8 A
- Low Gate Charge (Typ. 12 nC)
- Low Crss (Typ. 5 pF)
- 100% Avalanche Tested
- RoHS Compliant



Absolute Maximum Ratings T_C = 25°C unless otherwise noted

| Symbol | Parameter | | FQD2N100TM / FQU2N100TU | Unit | |
|-----------------------------------|--|----------|-------------------------|------|--|
| V _{DSS} | Drain-Source Voltage | | 1000 | V | |
| I _D | Drain Current - Continuous (T _C = 25°C) - Continuous (T _C = 100°C) | | 1.6 | Α | |
| | | | 1.0 | Α | |
| I _{DM} | Drain Current - Pulsed | (Note 1) | 6.4 | Α | |
| V _{GSS} | Gate-Source Voltage | | ± 30 | V | |
| E _{AS} | Single Pulsed Avalanche Energy (Note 2) | | 160 | mJ | |
| I _{AR} | Avalanche Current | (Note 1) | 1.6 | Α | |
| E _{AR} | Repetitive Avalanche Energy | (Note 1) | 5.0 | mJ | |
| dv/dt | Peak Diode Recovery dv/dt | (Note 3) | 5.5 | V/ns | |
| P_{D} | Power Dissipation (T _A = 25°C) * | | 2.5 | W | |
| _ | Power Dissipation (T _C = 25°C) | | 50 | W | |
| | - Derate above 25°C | | 0.4 | W/°C | |
| T _J , T _{STG} | Operating and Storage Temperature Range | | -55 to +150 | °C | |
| T _L | Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds | | 300 | °C | |

Thermal Characteristics

| Symbol | Parameter | FQD2N100TM FQU2N100TU | Unit | |
|-----------------|--|--------------------------|------|--|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case, Max. | 2.5 | | |
| В | Thermal Resistance, Junction to Ambient (minimum pad of 2 oz copper), Max. | 110 | °C/W | |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (* 1 in² pad of 2 oz copper), Max. | 50 | İ | |

12

2.5

6.5

15.5

nC

nC

nC

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity | |
|----------------|------------|---------|-----------|------------|----------|--|
| FQD2N100 | FQD2N100TM | DPAK | 330 mm | 16 mm | 2500 | |
| FQU2N100 | FQU2N100TU | IPAK | - | - | 70 | |

Flectrical Characteristics

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Unit |
|---|--|--|------|-------|------|------|
| Off Cha | racteristics | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | V_{GS} = 0 V, I_{D} = 250 μ A | 1000 | | | V |
| ΔBV _{DSS} / ΔT _J | Breakdown Voltage Temperature Coefficient | I_D = 250 μA, Referenced to 25°C | : | 0.976 | | V/° |
| I _{DSS} | 7 0 1 1/1 1 5 1 0 1 | V _{DS} = 1000 V, V _{GS} = 0 V | | | 10 | μΑ |
| | Zero Gate Voltage Drain Current | V _{DS} = 800 V, T _C = 125°C | | | 100 | μΑ |
| I _{GSSF} | Gate-Body Leakage Current, Forward | V _{GS} = 30 V, V _{DS} = 0 V | | | 100 | nA |
| I _{GSSR} | Gate-Body Leakage Current, Reverse | V _{GS} = -30 V, V _{DS} = 0 V | | | -100 | n/ |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$ | 3.0 | | 5.0 | V |
| On Cha | racteristics | | | | | |
| R _{DS(on)} | Static Drain-Source On-Resistance | $V_{GS} = 10 \text{ V}, I_D = 0.8 \text{ A}$ | | 7.1 | 9 | Ω |
| g _{FS} | Forward Transconductance | V _{DS} = 50 V, I _D = 0.8 A | | 1.9 | | S |
| | ic Characteristics | | · | | | |
| C _{iss} | Input Capacitance | V = 25 V V = 0 V | | 400 | 520 | pF |
| C _{oss} | Output Capacitance | $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz | | 40 | 52 | pF |
| C _{rss} | Reverse Transfer Capacitance | 1 - 1.0 WH12 | | 5 | 6.5 | pF |
| Switchi | ng Characteristics | | | | | |
| t _{d(on)} | Turn-On Delay Time | V _{DD} = 500 V, I _D = 2.0 A, | | 13 | 35 | ns |
| t _r | Turn-On Rise Time | $R_G = 25 \Omega$ | | 30 | 70 | ns |
| t _{d(off)} | Turn-Off Delay Time | | | 25 | 60 | ns |
| t _f | Turn-Off Fall Time | (Note 4 |) | 35 | 80 | ns |

| Drain-Source | Diode | Characteristics | and Ma | aximum | Ratings |
|---------------------|-------|------------------------|--------|--------|---------|

| I_S | Maximum Continuous Drain-Source Diode Forward Current | | | 1.5 | Α |
|-----------------|---|--|---------|-----|----|
| I _{SM} | Maximum Pulsed Drain-Source Diode Forward Current | | | 6.0 | Α |
| V _{SD} | Drain-Source Diode Forward Voltage | V _{GS} = 0 V, I _S = 1.6 A | | 1.4 | V |
| t _{rr} | Reverse Recovery Time | V _{GS} = 0 V, I _S = 2.0 A, | 520 | | ns |
| Q _{rr} | Reverse Recovery Charge | dI _F / dt = 100 A/μs | 2.3 | - | μС |

 V_{GS} = 10 V

 V_{DS} = 800 V, I_{D} = 2.0 A,

 Q_g

Q_{gs}

 Q_{gd}

Notes:1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 120mH, I_{AS} = 1.6A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25°C 3. $I_{SD} \leq$ 2.0A, di/dt \leq 300A/µs, $V_{DD} \leq$ BVDss, Starting T_{J} = 25°C 4. Essentially independent of operating temperature

Total Gate Charge

Gate-Source Charge

Gate-Drain Charge

Typical Characteristics

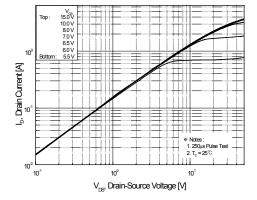


Figure 1. On-Region Characteristics

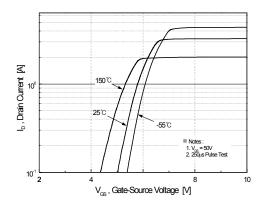


Figure 2. Transfer Characteristics

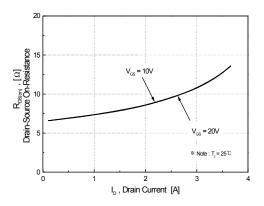


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

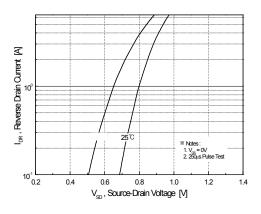


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

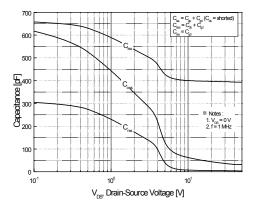


Figure 5. Capacitance Characteristics

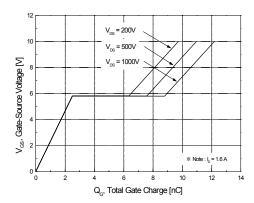


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)

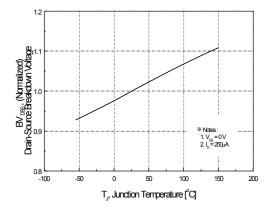


Figure 7. Breakdown Voltage Variation vs. Temperature

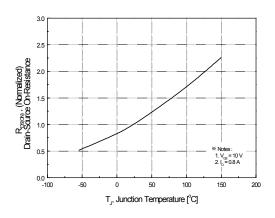


Figure 8. On-Resistance Variation vs. Temperature

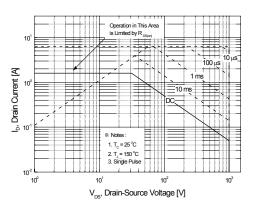


Figure 9. Maximum Safe Operating Area

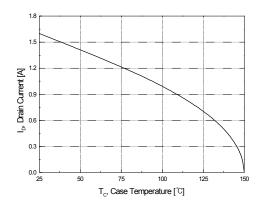


Figure 10. Maximum Drain Current vs. Case Temperature

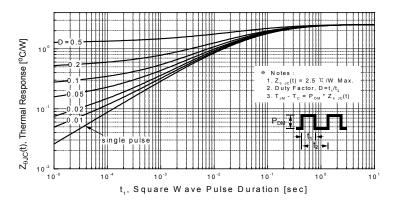


Figure 11. Transient Thermal Response Curve



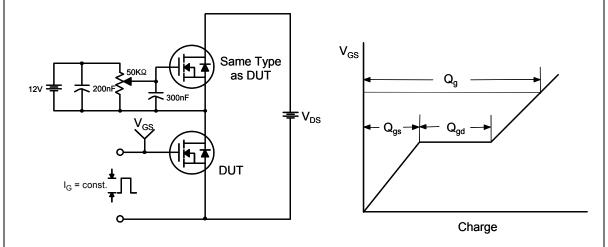


Figure 13. Resistive Switching Test Circuit & Waveforms

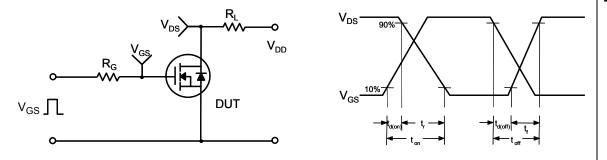


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms

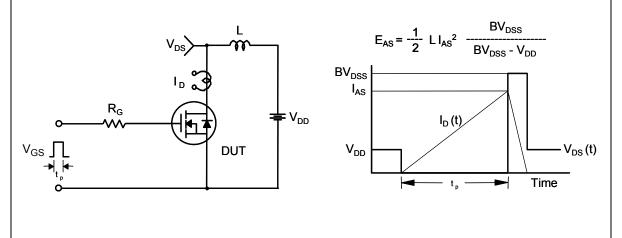
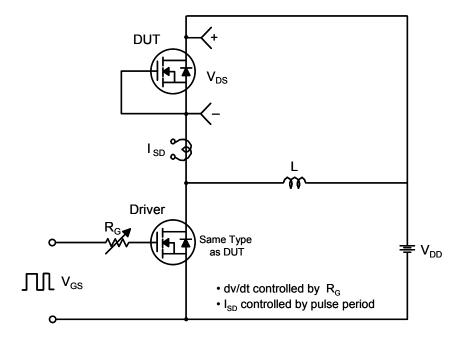
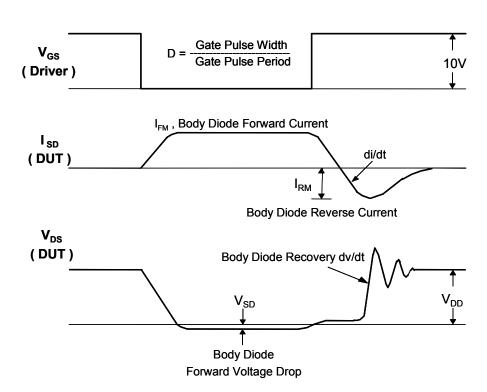


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms





Mechanical Dimensions

TO-252 3L (DPAK)

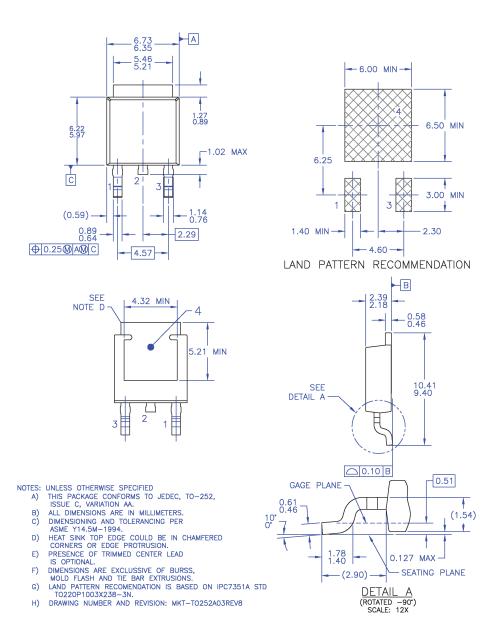


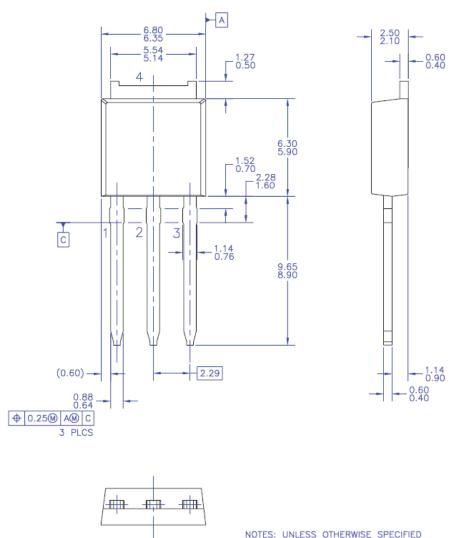
Figure 16. TO252 (D-PAK), Molded, 3 Lead, Option AA&AB

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Dimension in Millimeters

Mechanical Dimensions

TO-251 3L (IPAK)



- ALL DIMENSIONS ARE IN MILLIMETERS.
- THIS PACKAGE CONFORMS TO JEDEC, TO-251, ISSUE C, VARIATION AA, DATED SEP 1988.
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.

Figure 17. TO-251 (I-PAK) Molded, 3 Lead Option AA

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Dimension in Millimeters

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